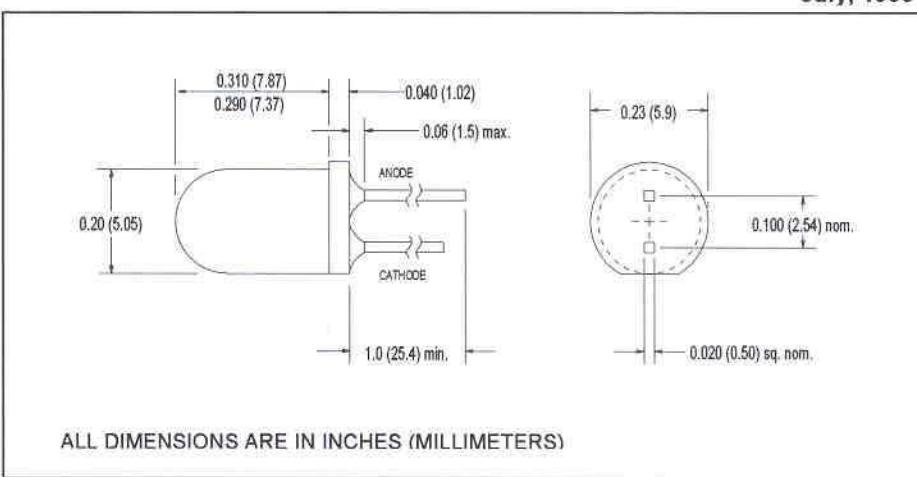


CLD370F

Plastic PIN Photodiode



July, 1999



ALL DIMENSIONS ARE IN INCHES (MILLIMETERS)

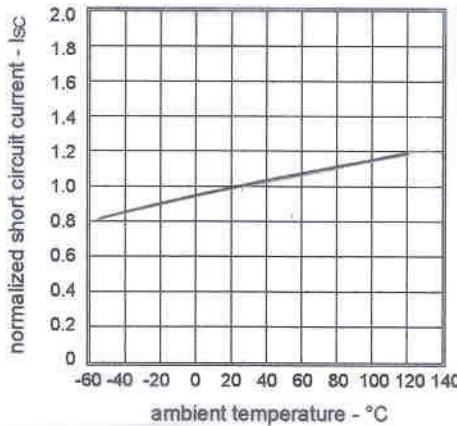
features

- fast switching speed
- low junction capacitance
- 850 nm peak response
- sharp cutoff to visible wavelengths
- large photosensitive area
- $\pm 30^\circ$ acceptance angle

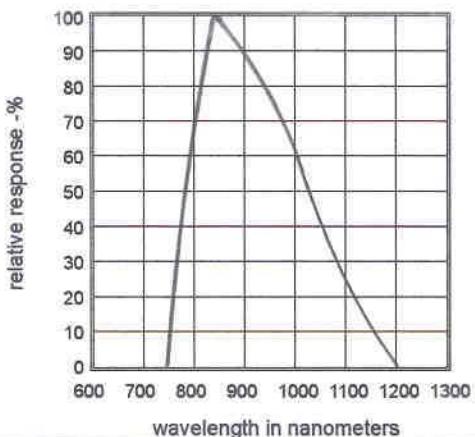
description

The CLD370F is a high gain silicon photodiode mounted in a T-1 1/4 dark plastic package. The chip has an active area of approximately $0.080'' \times 0.080''$ (4 square mm) and is intended for use as an infrared sensor. The dark tinting of the package effectively attenuates wavelengths shorter than 700nm which eliminates most visible light interference.

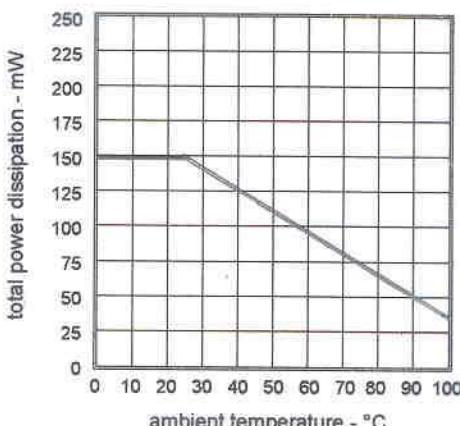
normalized short circuit current
vs ambient temp.



fundamental characteristics
spectral response



total power dissipation
vs ambient temp.



Clairex reserves the right to make changes at any time to improve design and to provide the best possible product.

Revised 12/01/04

CLD370F

Plastic PIN Photodiode



electrical characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

symbol	parameter	min	typ	max	units	test conditions
I_{SC}	Short-circuit current ⁽¹⁾	5.0 -	10.0 60.0	-	μA μA	$V_R = 5\text{V}, E_e = 0.1\text{mW/cm}^2$ $V_R = 5\text{V}, E_e = 1.0\text{mW/cm}^2$
I_D	Dark current	-	-	30	nA	$V_R = 10\text{V}, E_e = 0$
V_{BR}	Reverse breakdown	30	-	-	V	$I_R = 100\mu\text{A}, E_e = 0$
C_J	Junction capacitance	-	25	-	pF	$V_R = 3\text{V}, E_e = 0, f = 1\text{MHz}$
V_O	Open circuit voltage ⁽¹⁾	-	350	-	mV	$E_e = 0.1\text{mW/cm}^2$
θ_{HP}	Total angle at half sensitivity points	-	60	-	deg.	
t_r, t_f	Output rise and fall time ⁽¹⁾	-	30	-	ns	$R_L = 1\text{k}\Omega, V_R = 10\text{V}$

note: 1. Radiation source is an aluminum gallium arsenide IRED operating at a peak emission wavelength of 850nm.

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